Docket No.: 2336-254 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Inventor(s): Sun Woon KIM et al.

U.S. Patent Application No.: Not yet assigned

Group Art Unit: Not yet assigned

Filed: Herewith

For: FABRICATION METHOD OF NITRIDE SEMICONDUCTORS AND NITRIDE

SEMICONDUCTOR STRUCTURE FABRICATED THEREBY

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The attached references appear in the specification.

Respectfully submitted

LOWE HAUPTMAN GILMAN & BERNER, LLP

Benjamin /. Haypiman Registration No./29,310

1700 Diagonal Road, Suite 300 Alexandria, Virginia 22314 (703) 684-1111 Facsimile: (703) 518-5499

Date: March 23, 2004

BJH/ayh

INFORMATION DISCLOSURE				ATTY. DOCKET NO. 2336-254		U.S. APPLICATION NO. Not yet assigned		
	CITATIO APPLIC			APPLICANT Sun Woon K	IM et al.			
(PTO-1449)				FILING DATE herewith		GROUP Not yet assigned		
		U.S. PAI	ENT DO	CUMENTS			*** * * .	
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME Nakamura Lee		CLASS	SUBCLASS	FIL	JING ATE
	5,290,393	03/1994						
	6,528,394	03/2003						
					_			
	11 (1.40)							
EXAMINER'S		FOREIGN P	ATENT I	OCUMENTS				
INITIALS	PATENT NO.	DATE	COUNTRY		CLASS	SUBCLASS	Transl Yes	ation No
	2000-0055374	09/2000	Republic of Korea				165	140
								
7 See 1 20 1	OTHER	APT (Includes A	d					
20 - 21 - 11 - 21 - 21 - 21 - 21 - 21 -		ART (Including Au	inor, 1 iti	e, Date, Pertinen	t Pages, Etc.)		
								
	-							
WALERT								
XAMINER			DA.	TE CONSIDERE	<u> </u>	•		

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.